

**Search Notes**

Application/Control No.

09/776,669

Examiner

Stefano Karmis

Applicant(s)/Patent under  
Reexamination

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Art Unit

3624

**SEARCHED**

Class	Subclass	Date	Examiner
705	35	9/19/05	AL
705	37	9/19/05	AL
705	39	9/19/05	AL
705	40	9/19/05	AL
705	42	9/19/05	AL
705	44	9/19/05	AL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST KEYWORDS (A77ACITEN)	9/19/05	AL